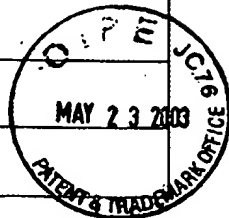


Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-063001	Application No. 09/919,832
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Shunpei Yamazaki et al.	
		Filing Date August 2, 2001	Group Art Unit 2673



U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
MF	AA	US 2002/0021274 A1	02/21/2002	Koyama et al.			08/08/2001
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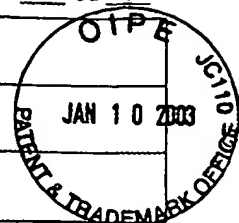
Technology Center

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
MF	AL	EP 1 182 638 A2	02/27/2002	Europe				
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature <i>M. F. [Signature]</i>	Date Considered 9/3/04
EXAMINER: Initials/citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-063001	Application No. 09/919,832
	Applicant Shunpei Yamazaki et al.		
	Filing Date August 2, 2001	Group Art Unit 2673	



U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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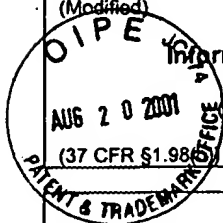
Technology Center 2600

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
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MF	AL	EP 1 098 290 A2	05/09/2001	Europe	—	—		
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	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature <i>M. Salas</i>	Date Considered 9/3/04
EXAMINER: initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-063001	Application No. 09/919,832
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)		Applicant Shunpei Yamazaki et al.	
		Filing Date August 2, 2001	Group Art Unit Unknown

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Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	AB						
	AC						

**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
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	AF							
	AG							
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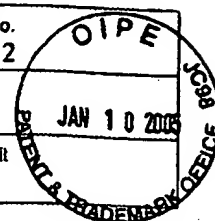
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**Other Documents (include Author, Title, Date, and Place of Publication)**

Examiner Initial	Desig. ID	Document
MF	AI	Shimoda et al.; "Current Status and Future of Light-Emitting Polymer Display Driven by Poly-Si TFT"; <u>SID 99 Digest</u> ; pp. 372-375; 1999
MF	AJ	Shimoda et al.; "High Resolution Light Emitting Polymer Driven by Low Temperature Polysilicon Thin Film Transistor with Integrated Driver"; <u>ASIA DISPLAY 98</u> ; pp. 217-220; 1998
MF	AK	Han et al.; "Green OLED with low temperature poly Si TFT"; <u>Euro Display 99 Late-news Papers</u> ; pp. 27-30; 1999
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	AP	

Examiner Signature <i>M. Satchi</i>	Date Considered 9/3/04
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement</b> <b>by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 12732-063001	Application No. 09/919,832
	Applicant Shunpei Yamazaki et al.			
	Filing Date August 2, 2001		Group Art Unit 2673	



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MF	AB	2002/0003521 A1	01/10/2002	Matsueda et al.	—	—	04/16/1998
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MF	AF	2002/0024054 A1	02/28/2002	Koyama et al.	—	—	08/17/2001
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MF	AI	2002/0113763 A1	08/22/2002	Koyama	—	—	02/08/2002
MF	AJ	2003/0071772 A1	04/17/2003	Kimura	—	—	12/18/2002
MF	AK	4,432,610	02/21/1984	Kobayashi et al.	—	—	02/19/1981
MF	AL	4,752,118	06/21/1988	Johnson	—	—	10/14/1986
MF	AM	4,773,738	09/27/1988	Hayakawa et al.	—	—	08/25/1987
MF	AN	4,996,523	02/26/1991	Bell et al.	—	—	10/20/1988
MF	AO	5,091,722	02/25/1992	Kitajima et al.	—	—	10/03/1988
MF	AP	5,200,846	04/06/1993	Hiroki et al.	—	—	02/18/1992
MF	AQ	5,225,823	07/06/1993	Kanaly	—	—	12/04/1990
MF	AR	5,247,190	09/21/1993	Friend et al.	—	—	12/28/1990
MF	AS	5,349,366	09/20/1994	Yamazaki et al.	—	—	10/27/1992
MF	AT	5,424,752	06/13/1995	Yamazaki et al.	—	—	12/03/1993
MF	AU	5,471,225	11/28/1995	Parks	—	—	05/17/1994
MF	AV	5,479,283	12/26/1995	Kaneko et al.	—	—	10/11/1994
MF	AW	5,600,169	02/04/1997	Burgener et al.	—	—	03/21/1995
MF	AX	5,642,129	06/24/1997	Zavracky et al.	—	—	03/23/1994
MF	AY	5,699,078	12/16/1997	Yamazaki et al.	—	—	07/22/1992
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Examiner Signature 	Date Considered 6/7/05
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-063001	Application No. <b>OTPE</b> 09/919,832
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant <b>Shunpei Yamazaki et al.</b>	
		Filing Date <b>August 2, 2001</b>	Group Art Unit <b>2673</b>

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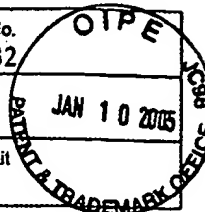
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
MF	ABB	5,907,313	05/25/1999	Kubota et al.	—	—	11/05/1996
MF	ACC	5,945,866	08/31/1999	Fonash et al.	—	—	02/27/1997
MF	ADD	5,990,629	11/23/1999	Yamada et al.	—	—	01/26/1998
MF	AEE	6,115,019	09/05/2000	Perner	—	—	02/25/1998
MF	AFF	6,165,824	12/26/2000	Takano et al.	—	—	03/03/1998
MF	AGG	6,246,386 B1	06/12/2001	Perner	—	—	06/18/1998
MF	AHH	6,259,846 B1	07/10/2001	Roach et al.	—	—	10/15/1999
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MF	AJJ	6,344,843 B1	02/05/2002	Koyama et al.	—	—	09/27/1995
MF	AKK	6,356,028 B1	03/12/2002	Legagneux et al.	—	—	03/02/2000
MF	ALL	6,366,026 B1	04/02/2002	Saito et al.	—	—	03/03/2000
MF	AMM	6,384,818 B1	05/07/2002	Yamazaki et al.	—	—	09/25/1997
MF	ANN	6,392,618 B1	05/21/2002	Kimura	—	—	07/16/1999
MF	AOO	6,441,829 B1	08/27/2002	Blalock et al.	—	—	11/18/1999
MF	APP	6,535,192 B1	03/18/2003	Sung et al.	—	—	08/21/2000
MF	AQQ	6,545,654 B2	04/08/2003	Jacobsen et al.	—	—	10/31/1996
MF	ARR	6,556,176 B1	04/29/2003	Okuyama et al.	—	—	03/24/2000
MF	ASS	6,630,916 B1	10/07/2003	Shinoda	—	—	12/03/1999
MF	ATT	6,670,938 B1	12/30/2003	Yoshida	—	—	02/16/2000
MF	AUU	6,765,562 B2	07/20/2004	Yamazaki et al.	—	—	02/19/2002
MF	AVV	6,774,876 B2	08/10/2004	Inukai	—	—	09/27/2001

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Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
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MF	AWW	EP 0 999 595 A2	05/10/2000	Europe	—	—	English	
MF	AXX	04-350627	12/04/1992	Japan	—	—	Full	
MF	AYY	06-102530	04/15/1994	Japan	—	—	Full	

Examiner Signature <i>M. [Signature]</i>	Date Considered <i>6/7/05</i>
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-063001	Application No. 09/919,832
Information Disclosure Statement by Applicant (Use several sheets if necessary)  (37 CFR §1.98(b))		Applicant Shunpei Yamazaki et al.	
		Filing Date August 2, 2001	Group Art Unit 2673



Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
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MF	AZZ	08-101609	04/16/1996	Japan	—	—	Abstract	
MF	AAAA	08-194205	07/30/1996	Japan	—	—	Full	
MF	ABBB	10-092576	04/10/1998	Japan	—	—	Abstract	
MF	ACCC	10-214060	08/11/1998	Japan	—	—	Abstract	
MF	ADDD	10-232649	09/02/1998	Japan	—	—	Abstract	
MF	AEEE	10-247735	09/14/1998	Japan	—	—	Abstract	
MF	AFFF	10-253941	09/25/1998	Japan	—	—	Abstract	
MF	AGGG	10-312173	11/24/1998	Japan	—	—	Full	

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
MF	AHHH	Schenk et al.; Polymers for Light Emitting Diodes; EuroDisplay '99; The 19 <sup>th</sup> International Display Research Conference; September 6-9, 1999; pages 33-37.
	AIII	
	AJJJ	
	AKKK	

Examiner Signature <i>M. Gatchew</i>	Date Considered 6/7/05
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Sheet 1 of 2

Substitute Form PTO 1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-063001	Application No. 09/919,832
	Applicant Shunpei Yamazaki et al.		
	Filing Date August 2, 2001	Group Art Unit 2674	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
MF	AA	2002/0000969 A1	01/03/2002	Ozawa			04/25/2001
MF	AB	2002/0018131 A1	02/14/2002	Kochi			05/15/2001
MF	AC	2002/0039087 A1	04/04/2002	Inukai			09/27/2001
MF	AD	2002/0057244 A1	05/16/2002	Koyama et al.			11/09/2001
MF	AE	2002/0089483 A1	07/11/2002	Yamazaki et al.			02/19/2002
MF	AF	2002/0130828 A1	09/19/2002	Yamazaki et al.			12/21/2001
MF	AG	2003/0067632 A1	04/10/2003	Ohta et al.			11/12/2002
MF	AH	2003/0098875 A1	05/29/2003	Kurokawa et al.			11/18/2002
MF	AI	2003/0103025 A1	06/05/2003	Kurokawa et al.			11/20/2002
MF	AJ	2004/0164322 A1	08/26/2004	Kondo et al.			08/14/2003
MF	AK	2004/0183766 A1	09/23/2004	Koyama et al.			04/05/2004
MF	AL	2004/0222955 A1	11/11/2004	Koyama			06/04/2004
MF	AM	5,125,045	06/23/1992	Murakami et al.			11/17/1988
MF	AN	5,339,090	08/16/1994	Crossland et al.			09/10/1992
MF	AO	5,608,549	03/04/1997	Usami			06/09/1992
MF	AP	5,673,422	09/30/1997	Kawai et al.			01/23/1995
MF	AQ	5,818,898	10/06/1998	Tsukamoto et al.			11/06/1996
MF	AR	5,841,482	11/24/1998	Wang et al.			12/16/1996
MF	AS	5,854,628	12/29/1998	Nakagawa			09/12/1995
MF	AT	5,959,598	09/28/1999	McKnight			02/09/1996
MF	AU	6,333,737 B1	12/25/2001	Nakajima			03/17/1999
MF	AV	6,335,728 B1	01/01/2002	Kida et al.			03/23/1999
MF	AW	6,344,672 B2	02/05/2002	Huffman			05/30/2001
MF	AX	6,380,876 B1	04/30/2002	Nagao			05/15/2000
MF	AY	6,445,368 B1	09/03/2002	Nakajima			11/17/2000
MF	AZ	6,496,130 B2	12/17/2002	Nagao			03/18/2002
MF	AAA	6,542,139 B1	04/01/2003	Kanno			04/07/2000

Examiner Signature <i>M. Patahger</i>	Date Considered <i>12/4/05</i>
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Disclosure Form (PTO-1449)

Sheet 2 of 2

Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. <b>12732-063001</b>	Application No. <b>09/919,832</b>
	Applicant <b>Shunpei Yamazaki et al.</b>		
	Filing Date <b>August 2, 2001</b>	Group Art Unit <b>2674</b>	

U.S. Patent Documents							
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MF	ABB	6,545,708 B1	04/08/2003	Tamayama et al.			07/07/1998
MF	ACC	6,564,237 B2	05/13/2003	Ohashi et al.			10/17/2001
MF	ADD	6,579,736 B2	06/17/2003	Yamazaki			04/17/2002
MF	AEE	6,664,943 B1	12/16/2003	Nakajima et al.			12/20/1999
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MF	AGG	6,731,264 B2	05/04/2004	Koyama et al.			11/09/2001
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MF	AII	09-212140	08/15/1997	JAPAN			AB
MF	AJJ	11-064814	03/05/1999	JAPAN			AB

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Examiner Initial	Desig. ID	Document
MF	AKK	U.S. Patent Application Office Action (Application No. 09/923,433) mailed July 28, 2004
MF	ALL	U.S. Patent Application Office Action (Application No. 09/930,956) mailed November 4, 2004
MF	AMM	U.S. Patent Application Office Action (Application No. 09/930,956) mailed April 19, 2004
MF	ANN	U.S. Patent Application Office Action (Application No. 09/969,591) mailed June 30, 2005
MF	AOO	U.S. Patent Application Office Action (Application No. 09/930,956) mailed October 28, 2003
MF	APP	U.S. Patent Application Office Action (Application No. 09/916,306) mailed January 25, 2005
MF	AQQ	U.S. Patent Application Office Action (Application No. 09/931,061) mailed March 22, 2005
MF	ARR	U.S. Patent Application Office Action (Application No. 09/930,956) mailed May 2, 2005
MF	ASS	China Patent Application Office Action (Application No. 001126012.2) mailed March 18, 2005

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Substitute Disclosure Form (PTO-1449)



Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-063001	Application No. 09/919,832
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Shunpei Yamazaki et al.	
		Filing Date August 2, 2001	Group Art Unit 2629

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Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	AU	6,583,775	06/24/2003	SEKIYA et al.			06/15/2000
	AV	6,611,301	08/26/2003	MURADE et al.			05/24/2002
	AW	6,621,477	09/16/2003	INOUE et al.			11/09/2000
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Examiner Signature /Mahmoud Fatahiyar/	Date Considered 03/17/2007
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-063001	Application No. 09/919,832
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Shunpei Yamazaki et al.	
		Filing Date August 2, 2001	Group Art Unit 2629

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/MF/	BB	6,731,272	05/04/2004	HUANG			01/22/2001
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	BG	6,940,482	09/06/2005	ISHII et al.			06/27/2002
	BH	6,958,741	10/25/2005	TSUTSUI			10/18/2002
	BI	6,987,496	01/17/2006	KOYAMA et al.			08/17/2001
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Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
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<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Shunpei Yamazaki et al.	
		Filing Date August 2, 2001	Group Art Unit 2629

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